Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/538,488	Reexamination TONAMI, JUNICH	IIRO
Examiner	Art Unit	
THOMAS D. ALUNKAL	2627	Page 1 of 1

U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0150016	10-2002	Yasuda et al.	369/53.22
*	В	US-2002/0101798	08-2002	Kim et al.	369/44.23
*	С	US-2003/0007431	01-2003	Tateishi, Kiyoshi	369/44.23
*	D	US-7,277,365	10-2007	Yasuda et al.	369/44.27
*	Е	US-7,151,735	12-2006	Arai et al.	369/112.05
*	F	US-6,728,179	04-2004	Nakano et al.	369/53.1
*	G	US-7,020,055	03-2006	Kim et al.	369/44.41
*	Н	US-2002/0060958	05-2002	Ando et al.	369/44.23
	Т	US-			
	J	US-			
	к	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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NON DATENT DOCUMENTS

NON-PATENT DOCUMENTS			
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